



SIGC109T120R3L

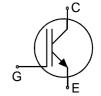
IGBT³ Chip

FEATURES:

- 1200V Trench + Field Stop technology
- 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

power module



Applications:

• drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC109T120R3L	1200V	100A	10.47 x 10.44 mm ²	sawn on foil	Q67050- A4210-A101

MECHANICAL PARAMETER:

Raster size	10.47 x 10.44			
Emitter pad size (include gate pad)	8.95 x 8.32			
Gate pad size	1.14 x 1.14			
Area total / active	109.3 / 85.8	mm ²		
Thickness	120	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	124 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, <500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



SIGC109T120R3L

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	100	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	200	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i diametei	Cymbol	Conditions	min.	typ.	max.	0
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 4 mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =100A	1.35	1.65	2.05	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =4mA , V _{GE} =V _{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			650	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =30V			600	nA
Integrated gate resistor	R _{Gint}			7.5		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiametei	Symbol	Conditions	min.	typ.	max.	Ullit
Input capacitance	Ciss	$V_{CE}=25V$,		7210		pF
Output capacitance	Coss	$V_{GE}=0V$,		377		
Reverse transfer capacitance	Crss	f=1MHz		327		

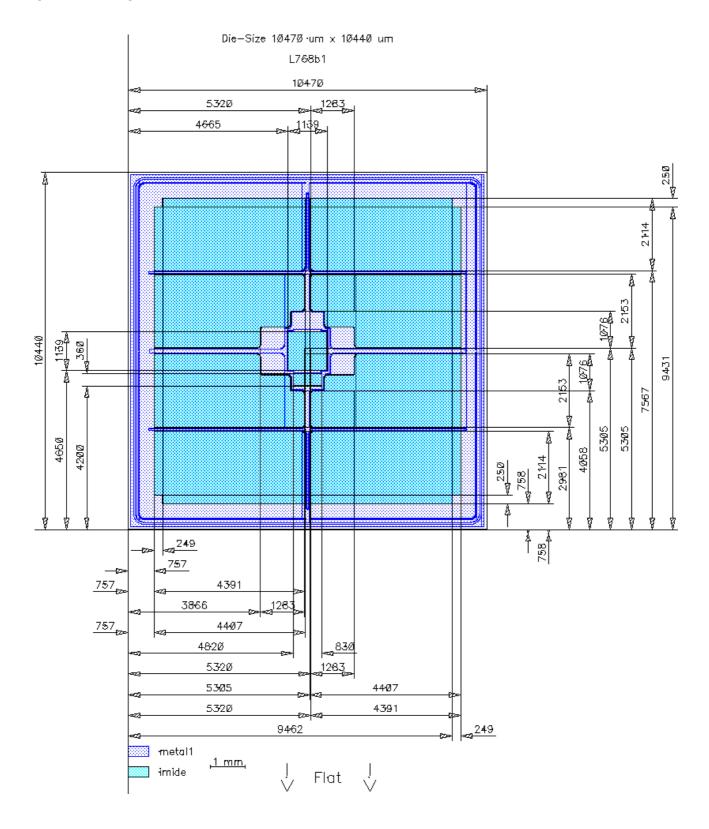
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
raidilletei	Symbol		min.	typ.	max.	Ullit
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =125°C $V_{\rm CC}$ =600V, $I_{\rm C}$ =100A, $V_{\rm GE}$ =-15/15V,		tbd		ns
Rise time	$t_{\rm r}$			tbd		
Turn-off delay time	$t_{d(off)}$			tbd		
Fall time	t _f	$R_{\rm G}$ = 3.9 Ω		tbd		



SIGC109T120R3L

CHIP DRAWING:





Preliminary

SIGC109T120R3L

FURTHER ELECTRICAL CHARACTERISTICS:

I his chip data sheet refers to the device data sheet	tbd	
DESCRIPTION:		
AQL 0,65 for visual inspection according to fa	ilure catalog	

Test-Normen Villach/Prüffeld

Published by Infineon Technologies AG i Gr., Bereich Kommunikation St.-Martin-Strasse 53, D-81541 München © Infineon Technologies AG 1999 All Rights Reserved.

Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

Electrostatic Discharge Sensitive Device according to MIL-STD 883

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.